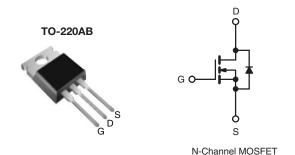


## **Power MOSFET**

| PRODUCT SUMMARY            |                        |      |  |  |  |  |
|----------------------------|------------------------|------|--|--|--|--|
| V <sub>DS</sub> (V)        | 200                    | 200  |  |  |  |  |
| R <sub>DS(on)</sub> (Ω)    | V <sub>GS</sub> = 10 V | 0.80 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC) | 14                     |      |  |  |  |  |
| Q <sub>gs</sub> (nC)       | 3.0                    | 3.0  |  |  |  |  |
| Q <sub>gd</sub> (nC)       | 7.9                    |      |  |  |  |  |
| Configuration              | Single                 |      |  |  |  |  |



## **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION |            |
|----------------------|------------|
| Package              | TO-220AB   |
| Lead (Pb)-free       | IRF620PbF  |
| Lead (PD)-liee       | SiHF620-E3 |
| SnPb                 | IRF620     |
| SIFD                 | SiHF620    |

| <b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwi |                         |                         | SYMBOL                            | LIMIT            | UNIT     |  |
|-------------------------------------------------------------------------|-------------------------|-------------------------|-----------------------------------|------------------|----------|--|
| Drain-Source Voltage                                                    |                         |                         | V <sub>DS</sub>                   | 200              |          |  |
| Gate-Source Voltage                                                     |                         |                         | V <sub>GS</sub>                   | ± 20             | V        |  |
| Continuous Dunin Comment                                                | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C  |                                   | 5.2              | А        |  |
| Continuous Drain Current                                                |                         | T <sub>C</sub> = 100 °C | I <sub>D</sub>                    | 3.3              |          |  |
| Pulsed Drain Current <sup>a</sup>                                       |                         |                         | I <sub>DM</sub>                   | 18               |          |  |
| Linear Derating Factor                                                  |                         |                         |                                   | 0.40             | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>                              |                         |                         | E <sub>AS</sub>                   | 110              | mJ       |  |
| Repetitive Avalanche Current <sup>a</sup>                               |                         |                         | I <sub>AR</sub>                   | 5.2              | Α        |  |
| Repetitive Avalanche Energy <sup>a</sup>                                |                         |                         | E <sub>AR</sub>                   | 5.0              | mJ       |  |
| Maximum Power Dissipation $T_C = 25  ^{\circ}C$                         |                         |                         | P <sub>D</sub>                    | 50               | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>                                  |                         |                         | dV/dt                             | 5.0              | V/ns     |  |
| Operating Junction and Storage Temperature Range                        |                         |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150    | °C       |  |
| Soldering Recommendations (Peak Temperature) for 10 s                   |                         |                         |                                   | 300 <sup>d</sup> |          |  |
| Mounting Torque                                                         | 6-32 or M3 screw        |                         |                                   | 10               | lbf ⋅ in |  |
| Mounting Torque                                                         |                         |                         |                                   | 1.1              | N⋅m      |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 6.1 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 5.2 \text{ A}$  (see fig. 12).
- c.  $I_{SD} \le 5.2 \text{ A}$ ,  $dI/dt \le 95 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_{J} \le 150 \text{ °C}$ .
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



| THERMAL RESISTANCE RATINGS          |                   |      |      |      |  |  |
|-------------------------------------|-------------------|------|------|------|--|--|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |  |  |
| Maximum Junction-to-Ambient         | R <sub>thJA</sub> | -    | 62   |      |  |  |
| Case-to-Sink, Flat, Greased Surface | R <sub>thCS</sub> | 0.50 | -    | °C/W |  |  |
| Maximum Junction-to-Case (Drain)    | R <sub>thJC</sub> | -    | 2.5  |      |  |  |

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS                                                                                       |                                                                                     | MIN. | TYP. | MAX.      | UNIT |
|-------------------------------------------|-----------------------|-------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|------|------|-----------|------|
| Static                                    |                       |                                                                                                       |                                                                                     |      |      |           |      |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>       | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$                                                         |                                                                                     | 200  |      | -         | V    |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_{J}$ | Reference                                                                                             | e to 25 °C, I <sub>D</sub> = 1 mA                                                   | -    | 0.29 | -         | V/°C |
| Gate-Source Threshold Voltage             | $V_{GS(th)}$          | V <sub>DS</sub> =                                                                                     | $V_{GS}$ , $I_{D} = 250  \mu A$                                                     | 2.0  | -    | 4.0       | V    |
| Gate-Source Leakage                       | $I_{GSS}$             |                                                                                                       | $V_{GS} = \pm 20 \text{ V}$                                                         | -    | -    | ± 100     | nA   |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>      |                                                                                                       | = 200 V, V <sub>GS</sub> = 0 V<br>V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C | -    | -    | 25<br>250 | μΑ   |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>   | $V_{DS} = 100 \text{ V}$                                                                              |                                                                                     | _    |      | 0.80      | Ω    |
| Forward Transconductance                  | 9fs                   |                                                                                                       | = 50 V, I <sub>D</sub> = 3.1 A                                                      | 1.5  | -    | -         | S    |
| Dynamic                                   | <u> </u>              |                                                                                                       |                                                                                     | L    |      |           |      |
| Input Capacitance                         | C <sub>iss</sub>      |                                                                                                       | V <sub>GS</sub> = 0 V,                                                              | -    | 260  | -         | pF   |
| Output Capacitance                        | Coss                  | _                                                                                                     | $V_{DS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$                                    | -    | 100  | -         |      |
| Reverse Transfer Capacitance              | C <sub>rss</sub>      | f = 1.0 MHz, see fig. 5                                                                               |                                                                                     | -    | 30   | -         | 1 .  |
| Total Gate Charge                         | Qg                    |                                                                                                       |                                                                                     | -    | -    | 14        |      |
| Gate-Source Charge                        | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V                                                                                | $I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$<br>see fig. 6 and 13 <sup>b</sup>    | -    | -    | 3.0       | nC   |
| Gate-Drain Charge                         | Q <sub>gd</sub>       |                                                                                                       | see lig. 6 and 13°                                                                  |      | -    | 7.9       |      |
| Turn-On Delay Time                        | t <sub>d(on)</sub>    | $V_{DD}$ = 100 V, $I_D$ = 4.8 A, $R_g$ = 18 $\Omega$ , $R_D$ = 20 $\Omega$ , see fig. 10 <sup>b</sup> |                                                                                     | -    | 7.2  | -         | - ns |
| Rise Time                                 | t <sub>r</sub>        |                                                                                                       |                                                                                     | -    | 22   | -         |      |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>   |                                                                                                       |                                                                                     | -    | 19   | -         |      |
| Fall Time                                 | t <sub>f</sub>        |                                                                                                       |                                                                                     | -    | 13   | -         |      |
| Internal Drain Inductance                 | L <sub>D</sub>        |                                                                                                       | Between lead,<br>6 mm (0.25") from                                                  |      | 4.5  | -         | ml l |
| Internal Source Inductance                | L <sub>S</sub>        | package and center of die contact                                                                     |                                                                                     | -    | 7.5  | -         | - nH |
| Drain-Source Body Diode Characteristic    | es                    | <u>.</u>                                                                                              |                                                                                     |      |      |           |      |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p - n junction diode                                       |                                                                                     | -    | 1    | 5.2       | A    |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>       |                                                                                                       |                                                                                     | -    | -    | 18        |      |
| Body Diode Voltage                        | V <sub>SD</sub>       | $T_J = 25  ^{\circ}\text{C},  I_S = 5.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$                  |                                                                                     | -    | -    | 1.8       | V    |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>       | $T_J = 25 ^{\circ}\text{C}$ , $I_F = 4.8 \text{A}$ , $dI/dt = 100 \text{A/}\mu\text{s}$               |                                                                                     | -    | 150  | 300       | ns   |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>       |                                                                                                       |                                                                                     | -    | 0.91 | 1.8       | μC   |
| Forward Turn-On Time                      | t <sub>on</sub>       | Intrinsic tu                                                                                          | rn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )                           |      |      |           |      |

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

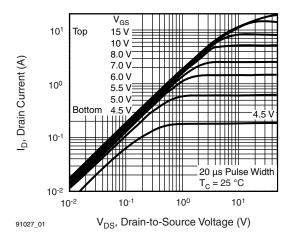


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

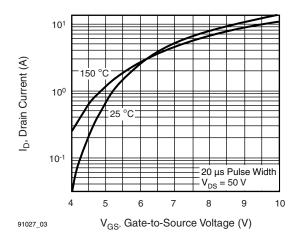


Fig. 3 - Typical Transfer Characteristics

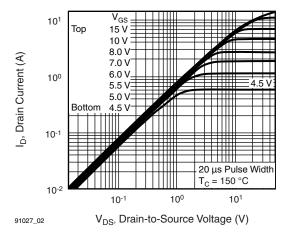


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

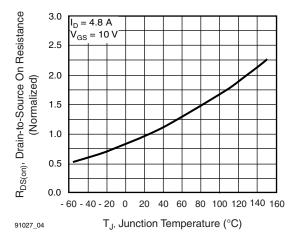


Fig. 4 - Normalized On-Resistance vs. Temperature



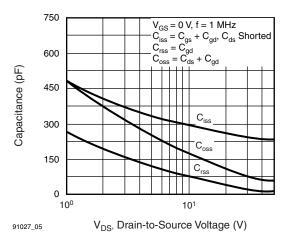


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

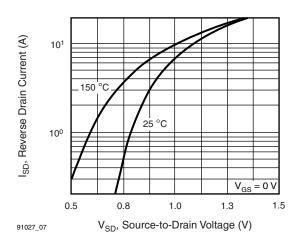


Fig. 7 - Typical Source-Drain Diode Forward Voltage

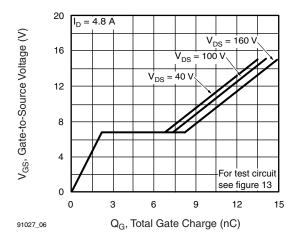


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

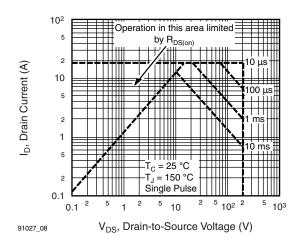


Fig. 8 - Maximum Safe Operating Area



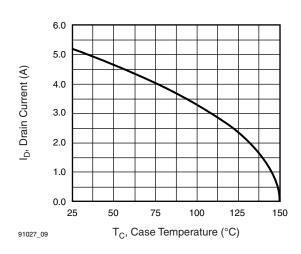


Fig. 9 - Maximum Drain Current vs. Case Temperature

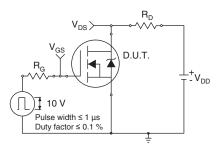


Fig. 10a - Switching Time Test Circuit

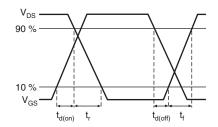


Fig. 10b - Switching Time Waveforms

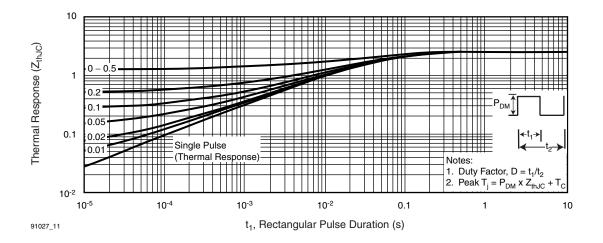


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

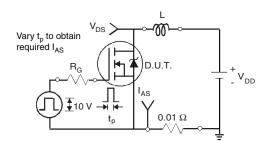


Fig. 12a - Unclamped Inductive Test Circuit

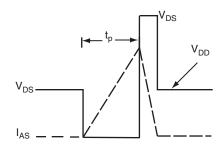


Fig. 12b - Unclamped Inductive Waveforms



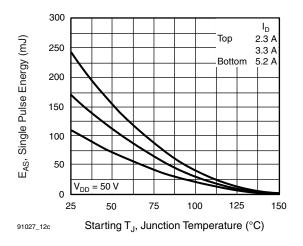


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

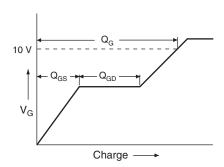


Fig. 13a - Basic Gate Charge Waveform

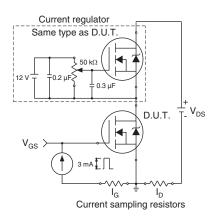
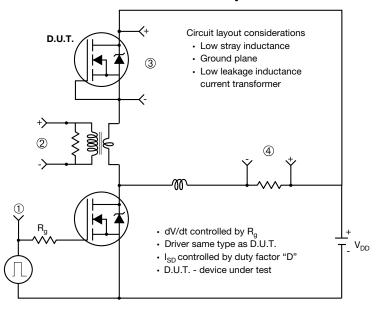


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



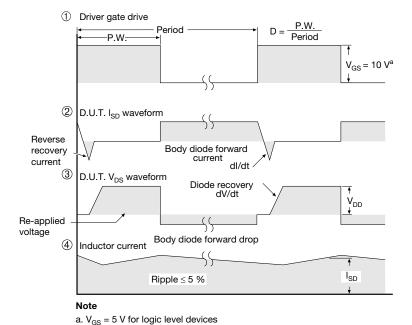
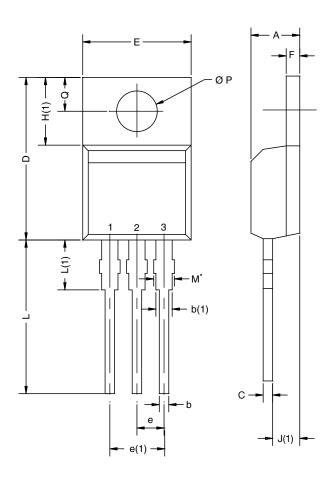


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91027.



# **TO-220AB**



|                                 | MILLIMETERS |       | INC   | HES   |  |  |
|---------------------------------|-------------|-------|-------|-------|--|--|
| DIM.                            | MIN.        | MAX.  | MIN.  | MAX.  |  |  |
| А                               | 4.25        | 4.65  | 0.167 | 0.183 |  |  |
| b                               | 0.69        | 1.01  | 0.027 | 0.040 |  |  |
| b(1)                            | 1.20        | 1.73  | 0.047 | 0.068 |  |  |
| С                               | 0.36        | 0.61  | 0.014 | 0.024 |  |  |
| D                               | 14.85       | 15.49 | 0.585 | 0.610 |  |  |
| Е                               | 10.04       | 10.51 | 0.395 | 0.414 |  |  |
| е                               | 2.41        | 2.67  | 0.095 | 0.105 |  |  |
| e(1)                            | 4.88        | 5.28  | 0.192 | 0.208 |  |  |
| F                               | 1.14        | 1.40  | 0.045 | 0.055 |  |  |
| H(1)                            | 6.09        | 6.48  | 0.240 | 0.255 |  |  |
| J(1)                            | 2.41        | 2.92  | 0.095 | 0.115 |  |  |
| L                               | 13.35       | 14.02 | 0.526 | 0.552 |  |  |
| L(1)                            | 3.32        | 3.82  | 0.131 | 0.150 |  |  |
| ØΡ                              | 3.54        | 3.94  | 0.139 | 0.155 |  |  |
| Q                               | 2.60        | 3.00  | 0.102 | 0.118 |  |  |
| ECN: T13-0724-Rev. O, 14-Oct-13 |             |       |       |       |  |  |

## DWG: 5471

Note

 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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Vishay

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Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as RoHS-Compliant fulfill the definitions and restrictions defined under Directive 2011/65/EU of The European Parliament and of the Council of June 8, 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (EEE) - recast, unless otherwise specified as non-compliant.

Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as Halogen-Free follow Halogen-Free requirements as per JEDEC JS709A standards. Please note that some Vishay documentation may still make reference to the IEC 61249-2-21 definition. We confirm that all the products identified as being compliant to IEC 61249-2-21 conform to JEDEC JS709A standards.

Revision: 02-Oct-12 Document Number: 91000